

NIF62514

Self-protected FET, Temp and Current Limit, Voltage Clamp, ESD, SOT-223

HDPlus devices are an advanced series of power MOSFETs which utilize ON Semiconductor's latest MOSFET technology process to achieve the lowest possible on-resistance per silicon area while incorporating smart features. Integrated thermal and current limits work together to provide short circuit protection. The devices feature an integrated Drain-to-Gate Clamp that enables them to withstand high energy in the avalanche mode. The Clamp also provides additional safety margin against unexpected voltage transients. Electrostatic Discharge (ESD) protection is provided by an integrated Gate-to-Source Clamp.

Features

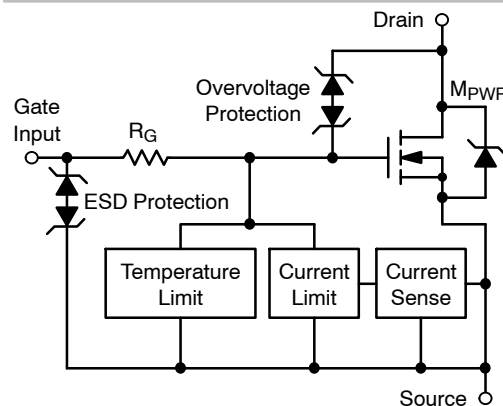
- Current Limitation
- Thermal Shutdown with Automatic Restart
- Short Circuit Protection
- Low $R_{DS(on)}$
- I_{DSS} Specified at Elevated Temperature
- Avalanche Energy Specified
- Slew Rate Control for Low Noise Switching
- Overvoltage Clamped Protection
- This is a Pb-Free Device



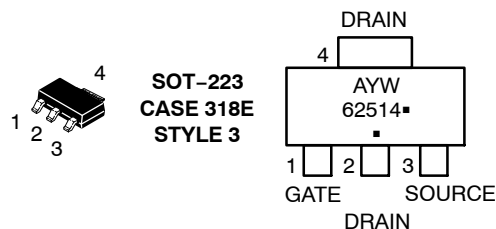
ON Semiconductor®

<http://onsemi.com>

6.0 AMPERES*
40 VOLTS CLAMPED
 $R_{DS(on)} = 90 \text{ m}\Omega$



MARKING DIAGRAM



A = Assembly Location
 Y = Year
 W = Work Week
 62514 = Specific Device Code
 ■ = Pb-Free Package
 (Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping†
NIF62514T1G	SOT-223 (Pb-Free)	1000/Tape & Reel
NIF62514T3G	SOT-223 (Pb-Free)	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

*Limited by the current limit circuit.

NIF62514

MOSFET MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	V_{DSS}	40	Vdc
Drain-to-Gate Voltage Internally Clamped ($R_{GS} = 1.0\text{ M}\Omega$)	V_{DGR}	40	Vdc
Gate-to-Source Voltage	V_{GS}	± 16	Vdc
Drain Current - Continuous @ $T_A = 25^\circ\text{C}$ - Continuous @ $T_A = 100^\circ\text{C}$ - Pulsed ($t_p \leq 10\ \mu\text{s}$)	I_D I_{D1} I_{DM}	Internally Limited	
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (Note 1) @ $T_A = 25^\circ\text{C}$ (Note 2) @ $T_A = 25^\circ\text{C}$ (Note 3)	P_D	1.1 1.73 8.93	W
Thermal Resistance, Junction-to-Tab Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)	$R_{\theta JT}$ $R_{\theta JA}$ $R_{\theta JA}$	14 114 72.3	$^\circ\text{C/W}$
Single Pulse Drain-to-Source Avalanche Energy ($V_{DD} = 25\text{ Vdc}$, $V_{GS} = 5.0\text{ Vdc}$, $V_{DS} = 40\text{ Vdc}$, $I_L = 2.8\text{ Apk}$, $L = 80\text{ mH}$, $R_G = 25\ \Omega$)	E_{AS}	300	mJ
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Mounted onto min pad board.
2. Mounted onto 1" pad board.
3. Mounted onto large heatsink.

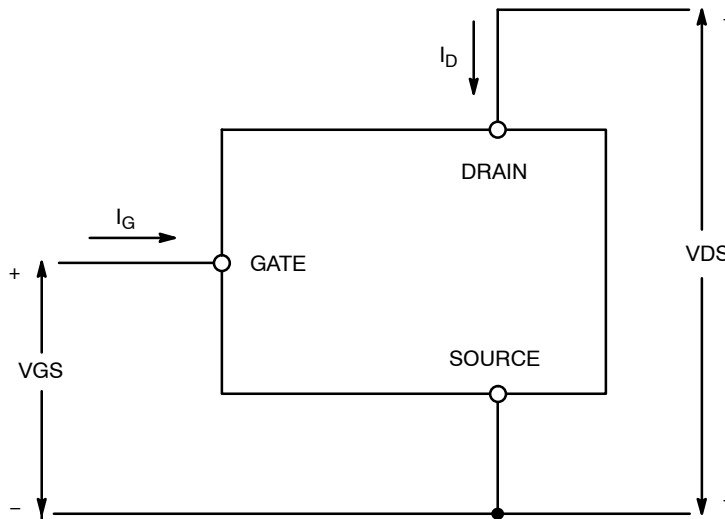


Figure 1. Voltage and Current Convention

NIF62514

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Clamped Breakdown Voltage (V _{GS} = 0 Vdc, I _D = 250 μAdc) (V _{GS} = 0 Vdc, I _D = 250 μAdc, T _J = 150°C) (Note 4)	V _{(BR)DSS}	42 42	46 45	50 50	Vdc
Zero Gate Voltage Drain Current (V _{DS} = 32 Vdc, V _{GS} = 0 Vdc) (V _{DS} = 32 Vdc, V _{GS} = 0 Vdc, T _J = 150°C) (Note 4)	I _{DSS}	– –	0.5 2.0	2.0 10	μAdc
Gate Input Current (V _{GS} = 5.0 Vdc, V _{DS} = 0 Vdc) (V _{GS} = -5.0 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	– –	50 550	100 1000	μAdc

ON CHARACTERISTICS

Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 150 μAdc) Threshold Temperature Coefficient (Negative)	V _{GS(th)}	1.0 –	1.7 4.0	2.0 –	Vdc mV/°C
Static Drain-to-Source On-Resistance (Note 5) (V _{GS} = 10 Vdc, I _D = 1.4 Adc, T _J @ 25°C) (V _{GS} = 10 Vdc, I _D = 1.4 Adc, T _J @ 150°C) (Note 4)	R _{DS(on)}	– –	90 165	100 190	mΩ
Static Drain-to-Source On-Resistance (Note 5) (V _{GS} = 5.0 Vdc, I _D = 1.4 Adc, T _J @ 25°C) (V _{GS} = 5.0 Vdc, I _D = 1.4 Adc, T _J @ 150°C) (Note 4)	R _{DS(on)}	– –	105 185	120 210	mΩ
Source-Drain Forward On Voltage (I _S = 7 A, V _{GS} = 0 V)	V _{SD}	–	1.05	–	V

SWITCHING CHARACTERISTICS (Note 4)

Turn-on Delay Time R _L = 4.7 Ω, V _{in} = 0 to 10 V, V _{DD} = 12 V	t _{d(on)}	–	4.0	8.0	μs
Turn-on Rise Time R _L = 4.7 Ω, V _{in} = 0 to 10 V, V _{DD} = 12 V	t _{rise}	–	11	20	μs
Turn-off Delay Time R _L = 4.7 Ω, V _{in} = 10 to 0 V, V _{DD} = 12 V	t _{d(off)}	–	32	50	μs
Turn-off Fall Time R _L = 4.7 Ω, V _{in} = 10 to 0 V, V _{DD} = 12 V	t _{fall}	–	27	50	μs
Slew-Rate On R _L = 4.7 Ω, V _{in} = 0 to 10 V, V _{DD} = 12 V	-dV _{DS} /dt _{on}	–	1.5	2.5	μs
Slew-Rate Off R _L = 4.7 Ω, V _{in} = 10 to 0 V, V _{DD} = 12 V	dV _{DS} /dt _{off}	–	0.6	1.0	μs

SELF PROTECTION CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Current Limit (V _{GS} = 5.0 Vdc) (V _{GS} = 5.0 Vdc, T _J = 150°C) (Note 4)	I _{LIM}	6.0 3.0	9.0 5.0	11 8.0	Adc
Current Limit (V _{GS} = 10 Vdc) (V _{GS} = 10 Vdc, T _J = 150°C) (Note 4)	I _{LIM}	7.0 4.0	10.5 7.5	13 10	Adc
Temperature Limit (Turn-off) (Note 4)	T _{LIM(off)}	150	175	200	°C
Temperature Hysteresis (Note 4)	ΔT _{LIM(on)}	–	15	–	°C
Temperature Limit (Turn-off) (Note 4)	T _{LIM(off)}	150	165	185	°C
Temperature Hysteresis (Note 4)	ΔT _{LIM(on)}	–	15	–	°C

ESD ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000	–	–	V
Electro-Static Discharge Capability	Machine Model (MM)	ESD	400	–	–	V

4. Not subject to production testing.
5. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

TYPICAL ELECTRICAL CHARACTERISTICS

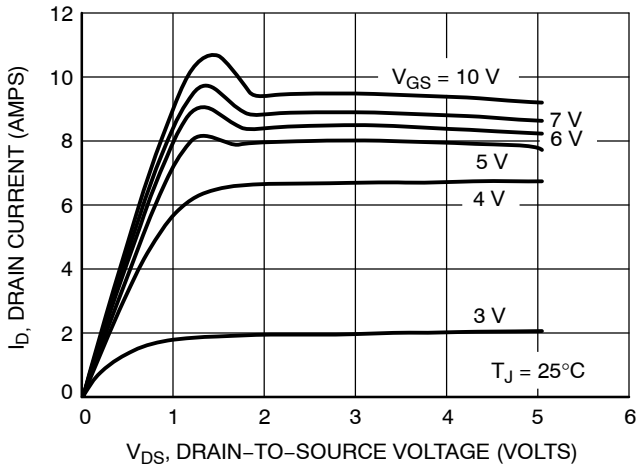


Figure 1. Output Characteristics

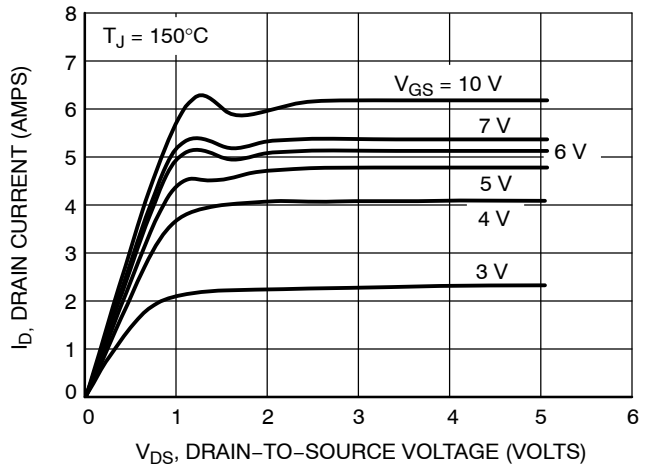


Figure 2. Output Characteristics

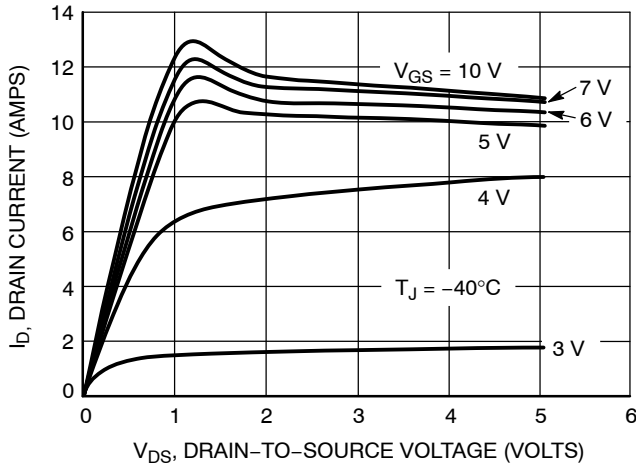


Figure 3. Output Characteristics

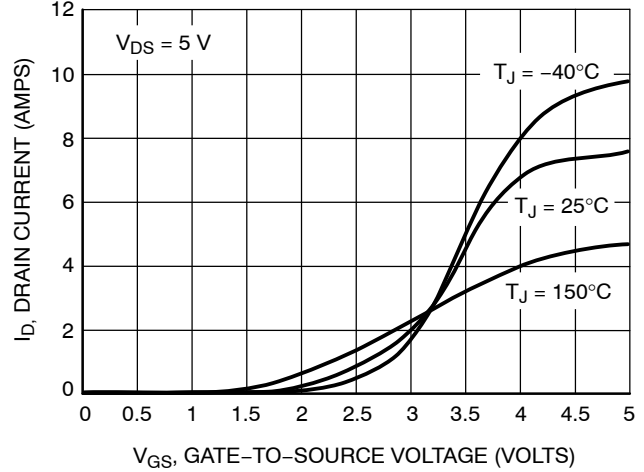


Figure 4. Transfer Characteristics

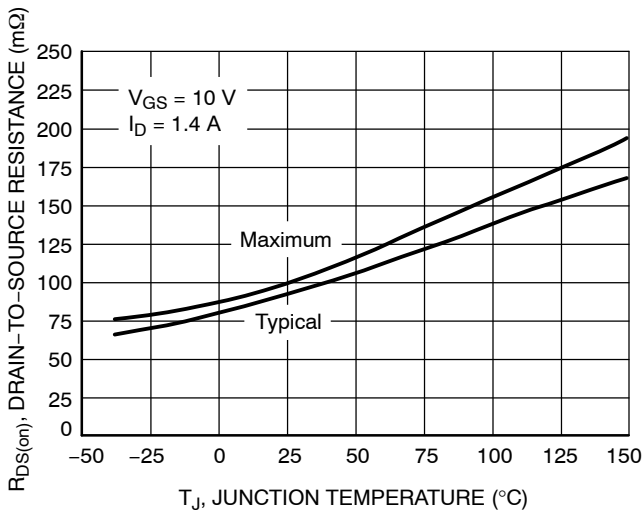


Figure 5. Drain-to-Source Resistance versus Junction Temperature

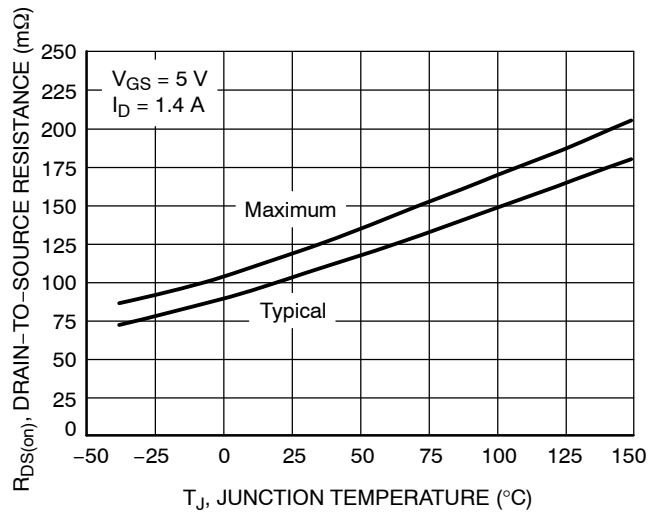


Figure 6. Drain-to-Source Resistance versus Junction Temperature

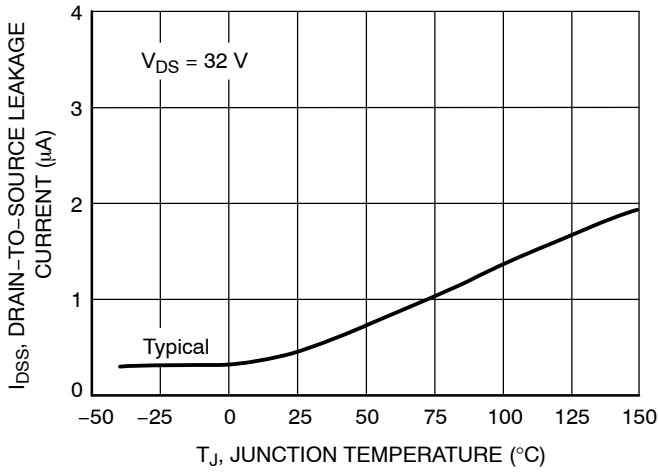


Figure 7. Drain-to-Source Resistance versus Junction Temperature

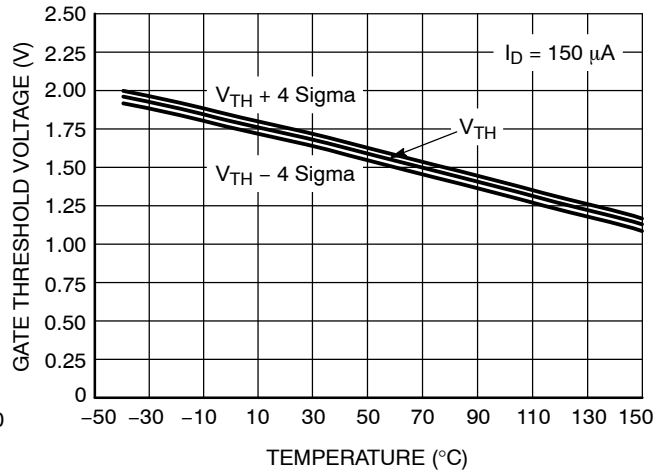


Figure 8. Gate Threshold Voltage versus Temperature

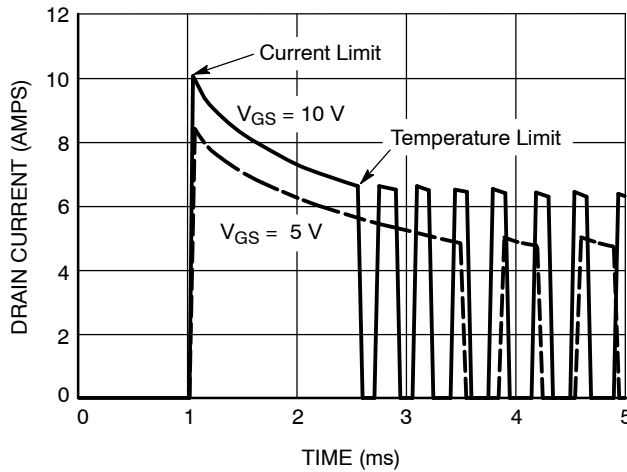


Figure 9. Short-circuit Response

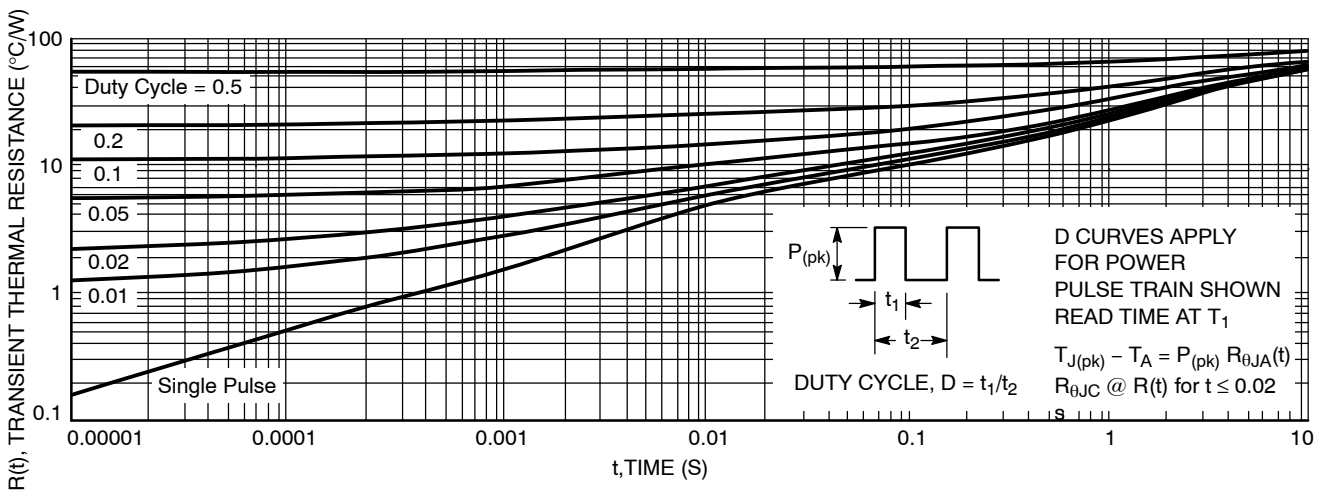


Figure 10. Transient Thermal Resistance (Non-normalized Junction-to-Ambient mounted on minimum pad area)

MECHANICAL CASE OUTLINE

PACKAGE DIMENSIONS

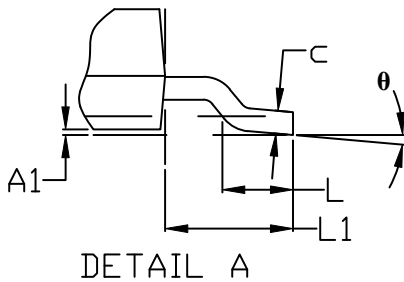
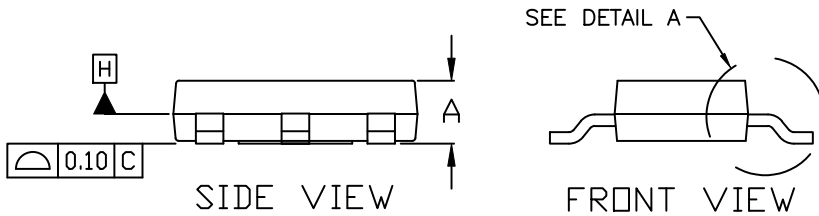
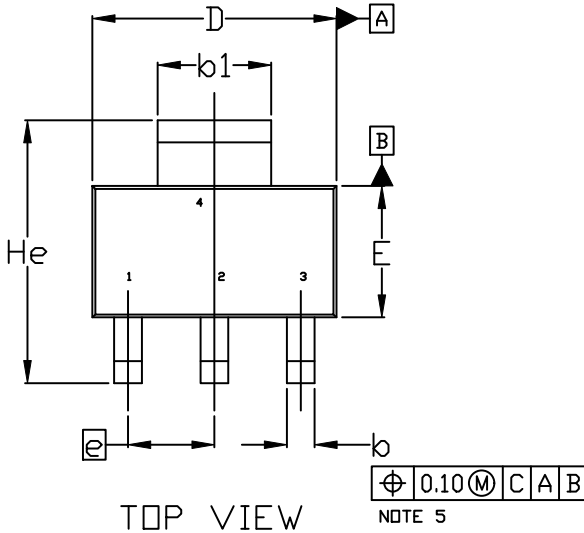
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SCALE 1:1

SOT-223 (TO-261)
CASE 318E-04
ISSUE R

DATE 02 OCT 2018



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
4. DATUMS A AND B ARE DETERMINED AT DATUM H.
5. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS b AND b1.

MILLIMETERS			
DIM	MIN.	NOM.	MAX.
A	1.50	1.63	1.75
A1	0.02	0.06	0.10
b	0.60	0.75	0.89
b1	2.90	3.06	3.20
c	0.24	0.29	0.35
D	6.30	6.50	6.70
E	3.30	3.50	3.70
e	2.30 BSC		
L	0.20	---	---
L1	1.50	1.75	2.00
He	6.70	7.00	7.30
θ	0°	---	10°



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SOT-223 (TO-261)
CASE 318E-04
ISSUE R

DATE 02 OCT 2018

- | | | | | |
|------------------------------------------------------------------------------|-----------------------------------------------------------------------------|-------------------------------------------------------------------------------|-----------------------------------------------------------------------|-----------------------------------------------------------------------|
| STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR | STYLE 2:
PIN 1. ANODE
2. CATHODE
3. NC
4. CATHODE | STYLE 3:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN | STYLE 4:
PIN 1. SOURCE
2. DRAIN
3. GATE
4. DRAIN | STYLE 5:
PIN 1. DRAIN
2. GATE
3. SOURCE
4. GATE |
| STYLE 6:
PIN 1. RETURN
2. INPUT
3. OUTPUT
4. INPUT | STYLE 7:
PIN 1. ANODE 1
2. CATHODE
3. ANODE 2
4. CATHODE | STYLE 8:
CANCELLED | STYLE 9:
PIN 1. INPUT
2. GROUND
3. LOGIC
4. GROUND | STYLE 10:
PIN 1. CATHODE
2. ANODE
3. GATE
4. ANODE |
| STYLE 11:
PIN 1. MT 1
2. MT 2
3. GATE
4. MT 2 | STYLE 12:
PIN 1. INPUT
2. OUTPUT
3. NC
4. OUTPUT | STYLE 13:
PIN 1. GATE
2. COLLECTOR
3. EMITTER
4. COLLECTOR | | |

**GENERIC
 MARKING DIAGRAM***




- A = Assembly Location
- Y = Year
- W = Work Week
- XXXXX = Specific Device Code
- = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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